Ultra Fast USB 2.0 Memory Stick Flash Media Controller

PRODUCT FEATURES

Datasheet

General Description

The SMSC USB2242/USB2242i is a USB 2.0 compliant, high speed Bulk Only Mass Storage Class Peripheral Controller intended for reading and writing to Memory Stick Flash Media Cards.

The SMSC USB2242/USB2242i is a fully integrated, single chip solution capable of ultra high performance operation. Average sustained transfer rates exceeding 35MB/s are possible if the media and host can support those rates. Provisions to read/write secure media formats is also provided.

General Features

- 36-pin QFN (6x6mm) lead-free RoHS compliant package
- Hardware-controlled data flow architecture for all self-mapped media
- Pipelined hardware support for access to non-self-mapped media
- Product name with “i” denotes the version that supports the industrial temperature range of -40ºC to 85ºC
- Support included for secure media format on a licensed, customized basis
  - Sony MagicGate™

Hardware Features

- Single Chip Flash Media Reader/Writer
  - Memory Stick Specification 1.43
  - Memory Stick Pro Format Specification 1.02
  - Memory Stick Pro-HG Duo Format Specification 1.01
    - Memory Stick, MS Duo, HS-MS, MS Pro-HG, MS Pro
- Extended configuration options
  - Socket switch polarities, etc.
- Media Activity LED
- GPIO configuration and polarity
  - Up to 8 GPIOs for special function use: LED indicators, power control to memory devices, etc. The number of actual GPIO’s depends on the implementation configuration used.
  - One GPIO with up to 200 mA drive
- On Board 24MHz Crystal Driver Circuit
- Internal Card Power FET
  - 200mA
  - "Fold-back" short circuit current protected
- 8051 8-bit microprocessor
  - 60MHz - single cycle execution
  - 64KB ROM; 14KB RAM
- Internal Regulator for 1.8V core operation
- Optimized pinout improves signal routing, easing implementation and allowing for improved signal integrity

Mask Programmable Features

- VID/PID/Language ID
- 28-character Manufacturer ID and Product string
- 12-hex digit (max) Serial Number string
- Customizable Vendor specific data LED blink interval or duration

Software Features

- Optimized for low latency interrupt handling
- Reduced memory footprint
- Please see the USB2242/USB2242i Software Release Notes for additional Software Features.

Applications

- Flash Media Card Reader/Writer
- Printers
- Desktop and Mobile PCs
- Consumer A/V
- Media Players/Viewers
- Vista ReadyBoost™
- Compatible with Microsoft Vista, Windows XP, Windows ME, Windows 2K SP4, Apple OSx, and Linux Mass Storage Class Drivers

ORDER NUMBER:

USB2242/USB2242i-AEZG-XX for 36 pin, QFN Lead-Free RoHS Compliant Package

"XX" in the order number indicates the internal ROM firmware revision level. Please contact your SMSC sales representative for more information.

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Chapter 1 Acronyms

MS: Memory Stick

MSC: Memory Stick Controller

PLL: Phase-Locked Loop

QFN: Quad Flat no Leads

RoHS: Restriction of Hazardous Substances Directive

SIE: Serial Interface Engine

Chapter 2 Block Diagram

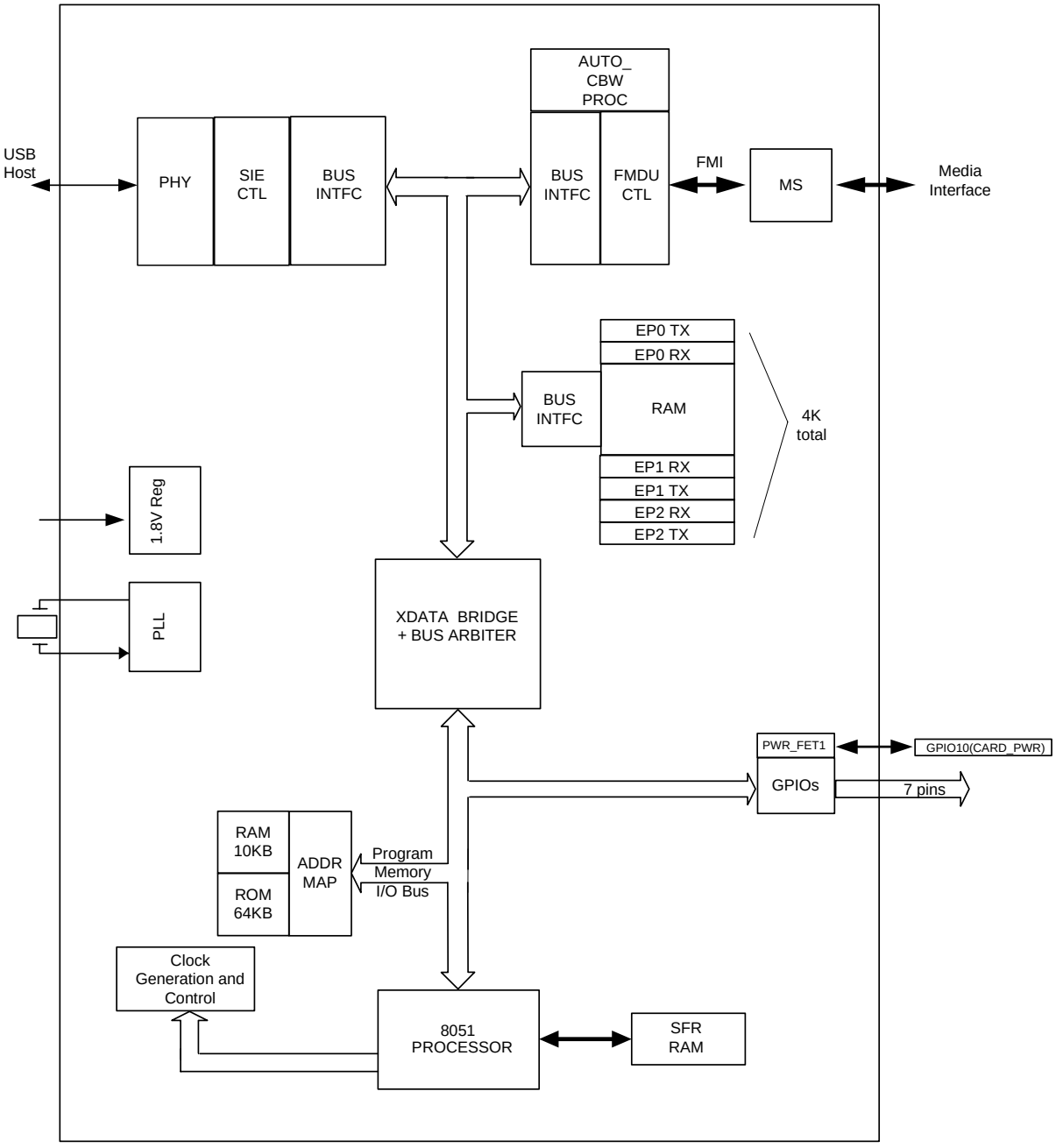


Figure 2.1 USB2242/USB2242i Block Diagram

Chapter 3 Pin Table

3.1 36-Pin Package

Table 3.1 USB2242/2242i 36-Pin QFN Package

MS INTERFACE (11 PINS)			
MS_D0	MS_D1	MS_D2	MS_D3
MS_D4	MS_D5	MS_D6	MS_D7
MS_BS	MS_SCLK	GPIO12 (MS_INS)	
USB INTERFACE (7 PINS)			
USB+	USB-	RBIAS	
XTAL1 (CLKIN)	XTAL2	VDDA33	VDD18PLL
MISC (14 Pins)			
GPIO1 (LED1)	GPIO2 / RXD / SDA	GPIO4	GPIO7 / TXD / SCK / MS_SKT_SEL
GPIO10 (CRD_PWR)	GPIO14	GPIO15	(5) NC
TEST	nRESET		
DIGITAL, POWER (4 PINS)			
(3) VDD33	VDD18		
TOTAL 36			

Chapter 4 Pin Configuration

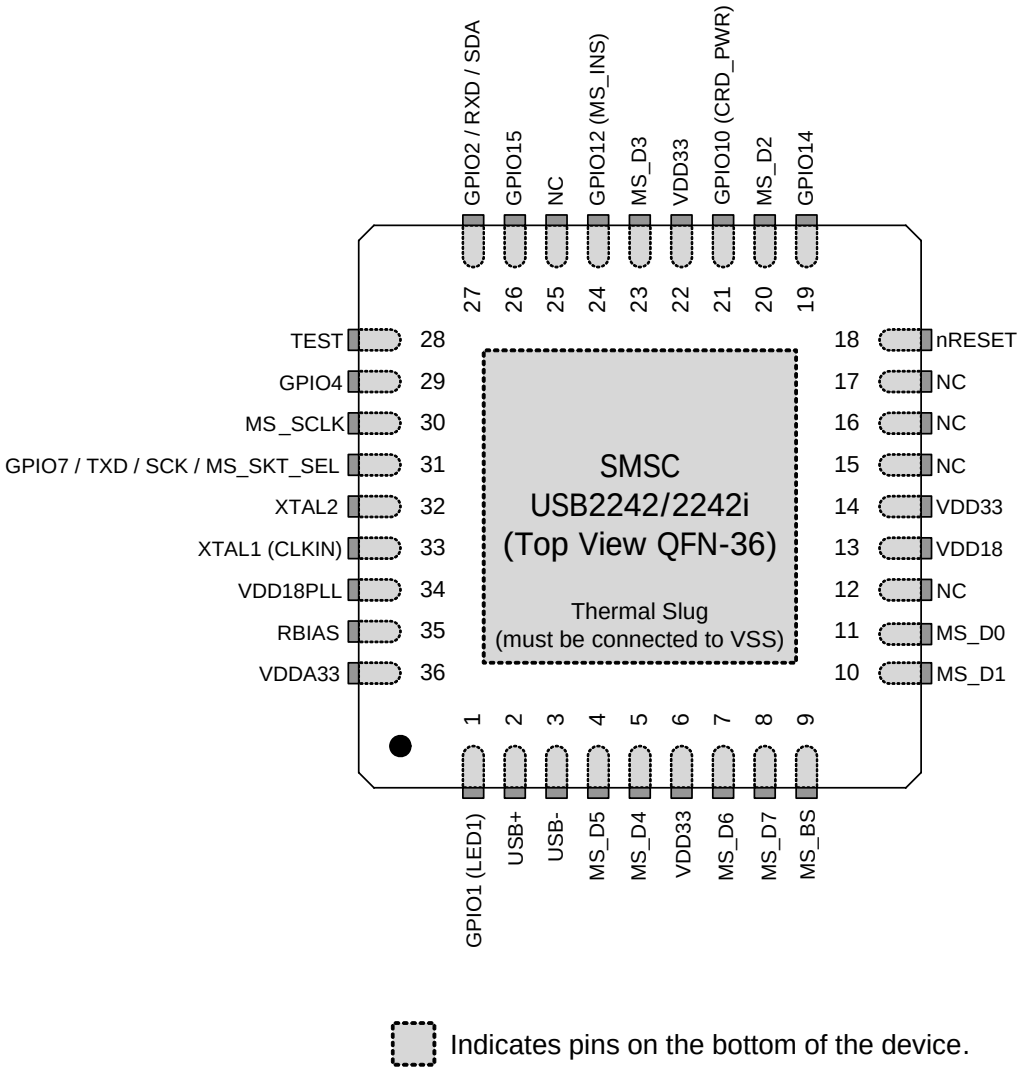


Figure 4.1 USB2242/USB2242i 36 Pin QFN Diagram

Chapter 5 Pin Descriptions

This section provides a detailed description of each signal. The signals are arranged in functional groups according to their associated interface.

The “n” symbol in the signal name indicates that the active, or asserted, state occurs when the signal is at a low voltage level. When “n” is not present before the signal name, the signal is asserted at the high voltage level.

The terms assertion and negation are used exclusively. This is done to avoid confusion when working with a mixture of “active low” and “active high” signals. The term assert, or assertion, indicates that a signal is active, independent of whether that level is represented by a high or low voltage. The term negate, or negation, indicates that a signal is inactive.

5.1 Pin Descriptions

Table 5.2 USB2242/2242i 36-Pin QFN Pin Descriptions

NAME	SYMBOL	36-PIN QFN	BUFFER TYPE	DESCRIPTION
MEMORY STICK INTERFACE				
MS System Data In/Out	MS_D[7:0]	8 7 4 5 23 20 10 11	I/O12PD	These pins are the bi-directional data signals for the MS device. In serial mode, the most significant bit (MSB) of each byte is transmitted first by either MSC or MS device on MS_D0. MS_D0, MS_D2, and MS_D3 have weak pull-down resistors. MS_D1 has a pull down resistor if it is in parallel mode, otherwise it is disabled. In 4 or 8 bit parallel mode, there is a weak pull-down resistor on all MS_D7 - 0 signals. The resistors are controlled by MSC_SYSTEM_0, MSC_MODE_CTL and MSC_PRO_HG registers.
MS Bus State	MS_BS	9	O12	This pin is connected to the BS pin of the MS device. It is used to control the Bus States 0, 1, 2 and 3 (BS0, BS1, BS2 and BS3) of the MS device.
MS System CLK	MS_SCLK	30	O12	This pin is an output clock signal to the MS device. The clock frequency is software configurable.
MS Card Insertion GPIO	GPIO12 (MS_INS)	24	IPU	This is a GPIO designated as the Memory Stick™ card detection pin.
USB INTERFACE				
USB Bus Data	USB+ USB-	2 3	I/O-U	These pins connect to the USB bus data signals.

Table 5.2 USB2242/2242i 36-Pin QFN Pin Descriptions (continued)

NAME	SYMBOL	36-PIN QFN	BUFFER TYPE	DESCRIPTION
USB Transceiver Bias	RBIAS	35	I-R	A 12.0k , 1.0% resistor is attached from VSSA to this pin in order to set the transceiver's internal bias currents.
24MHz Crystal or external clock input	XTAL1 (CLKIN)	33	ICLKx	This pin can be connected to one terminal of the crystal or it can be connected to an external 24 clock when a crystal is not used.
24MHz Crystal	XTAL2	32	OCLKx	This is the other terminal of the crystal, or it can be left open when an external clock source is used to drive XTAL1(CLKIN). It may not be used to drive any external circuitry other than the crystal circuit.
3.3V Analog Power	VDDA33	36		3.3V Analog Power
1.8V PLL Power	VDD18PLL	34		This pin is the 1.8V Power for the PLL. +1.8V Filtered analog power for internal PLL. This pin must have a 1.0µF(or greater) ±20% (ESR <0.1Ω) capacitor to VSS.
MISC				
General Purpose I/O	GPIO1 (LED1)	1	I/O12	This pin may be used either as input, edge sensitive interrupt input, or output. In addition, as an output, the GPIO1 can use output controlled by the LED1_GPIO1 register.
General Purpose I/O	GPIO2 / RXD / SDA	27	I/O12	GPIO: This pin may be used either as input, edge sensitive interrupt input, or output.
			I	RXD: In addition to the above, the signal can be used as input to the RXD of UART in the device, when the TXD_RXD_SEL bit in UTIL_CONFIG1 register is cleared to "0".
			I/O12	SDA: This is the data pin when used with an external serial EEPROM.
General Purpose I/O	GPIO4	29	I/O12	This pin may be used either as input, edge sensitive interrupt input, or output.

Table 5.2 USB2242/2242i 36-Pin QFN Pin Descriptions (continued)

NAME	SYMBOL	36-PIN QFN	BUFFER TYPE	DESCRIPTION
General Purpose I/O	GPIO7 / TXD / SCK / MS_SKT_SEL	31	I/O12	GPIO: This pin may be used either as input, edge sensitive interrupt input, or output.
			O12	TXD: In addition, as an output, the GPIO7 can be used as an output TXD of UART in the device, when the GPIO2/TXD bit in UTL_CONFIG register is set to "1"
			O12	SCK: This is the clock output when used with an external EEPROM.
			I	MS_SKT_SEL: On the positive edge of nRESET, this pin is sampled to determine the Memory Stick socket size. 1 = 8 bit 0 = 4 bit
General Purpose I/O	GPIO10 (CRD_PWR)	21	I/O200	GPIO: This pin may be used either as input, edge sensitive interrupt input, or output.
				CRD_PWR: Card Power drive of 3.3V @ either 100mA or 200mA.
General Purpose I/O	GPIO14	19	I/O12	This pin may be used either as input, edge sensitive interrupt input, or output.
General Purpose I/O	GPIO15	26	I/O12	This pin may be used either as input, edge sensitive interrupt input, or output.
RESET Input	nRESET	18	IS	This active low signal is used by the system to reset the chip. The active low pulse should be at least 1µs wide.
TEST Input	TEST	28	I	This signal is used for testing the chip. User should normally tie this pin low externally if the test function is not used.
No Connects	NC	12 15 16 17 25		No Connect. No trace or signal should be routed/attached to these pins.
DIGITAL / POWER				
+1.8V Core power	VDD18	13		+1.8V core power. This pin must have a 1.0µF (or greater) ±20% (ESR <0.1Ω) capacitor to VSS.
3.3V Power & Regulator Input.	VDD33	6 14 22		3.3V Power & Regulator Input.
Ground	VSS	SLUG		Ground Reference

5.2 Buffer Type Descriptions

Table 5.3 USB2242/USB2242i Buffer Type Descriptions

BUFFER	DESCRIPTION
I	Input.
IPU	Input with internal weak pull-up resistor.
IS	Input with Schmitt trigger.
I/O12	Input/Output buffer with 12mA sink and 12mA source.
I/O200	Input/Output buffer 12mA with FET disabled, 100/200mA source only when the FET is enabled.
I/O12PD	Input/Output buffer with 12mA sink and 12mA source, with an internal weak pull-down resistor.
O12	Output buffer with 12mA source.
ICLKx	XTAL clock input.
OCLKx	XTAL clock output.
I/O-U	Analog Input/Output Defined in USB specification.
I-R	RBIAS.

Chapter 6 Pin Reset State Table

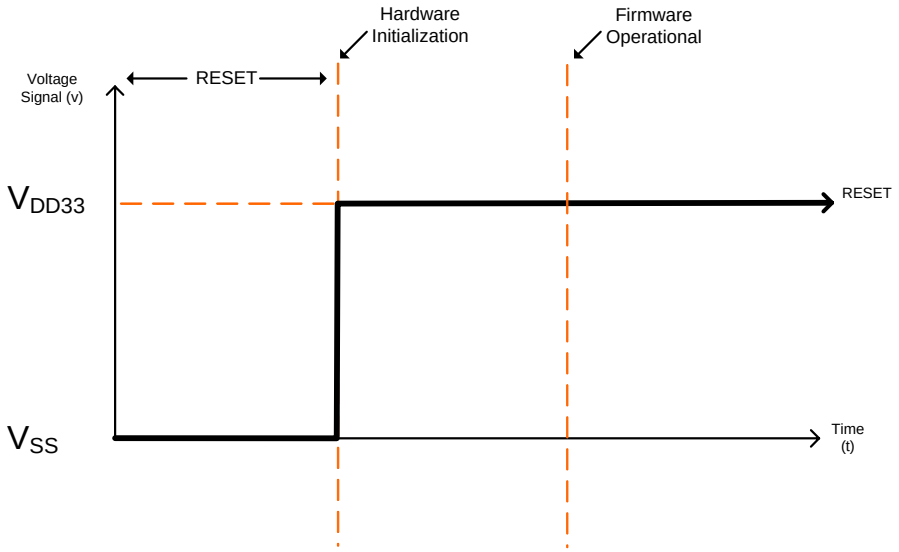


Figure 6.1 Pin Reset States

LEGEND	
yes	hardware enables function
--	hardware disables function
z	hardware disables output driver
pu	hardware enables pullup
pd	hardware enables pulldown
hw	hardware controls function, but state is protocol dependent
(fw)	firmware controls function through registers
VDD	hardware supplies power through pin, applicable only to CARD_PWR pins
none	hardware disables pad

Figure 6.2 Legend for Pin Reset States Table

6.1 36-Pin Reset States

Table 6.1 USB2242/USB2242i Pin Reset States

		RESET STATE				Post-Reset State MS Mode			
PIN	PIN NAME	FUNCTION	OUT-PUT	PU/ PD	IN-PUT	FUNCTION	OUT-PUT	PU/ PD	IN-PUT
8	MS_D7	none	z	--	--	MS_D7	hw	pd	yes
7	MS_D6	none	z	--	--	MS_D6	hw	pd	yes
5	MS_D4	none	z	--	--	MS_D4	hw	pd	yes
4	MS_D5	none	z	--	--	MS_D5	hw	hw	yes
30	MS_SCLK	SD_WP	0	--	--	MS_SCLK	hw	hw	--
25	NC	none	z	--	--	none	z	--	--
23	MS_D3	none	z	--	--	MS_D3	hw	pd	yes
20	MS_D2	none	z	--	--	MS_D2	hw	pd	yes
9	MS_BS	none	z	--	--	MS_BS	hw	hw	--
10	MS_D1	none	z	--	--	MS_D1	hw	hw	yes
11	MS_D0	none	z	--	--	MS_D0	hw	pd	yes
19	GPIO14	GPIO	z	pu	yes				
26	GPIO15	GPIO	z	pu	yes				
24	GPIO12 (MS_INS)	GPIO	z	pu	yes				
27	GPIO2 / RXD / SDA	GPIO	0	--	--				
29	GPIO4	GPIO	0	--	--				
31	GPIO7 / TXD / SCK / MS_SKT_SEL	GPIO	0	--	--				
21	GPIO10 (CARD_PWR)	GPIO	z	--	--				
28	TEST	TEST	z	--	yes				
18	nRESET	nRESET	z	--	yes				
1	GPIO1 (LED1)	GPIO1	0	--	--				
16	NC	none	z	--	--	none	z	--	--
12	NC	none	z	--	--	none	z	--	--
17	NC	none	z	--	--	none	z	--	--
15	NC	none	z	--	--	none	z	--	--
2	USB+	USB+	z	--	--				
3	USB-	USB-	z	--	--				
35	RBIAS								
33	XTAL1 (CLKIN)								
32	XTAL2								

Chapter 7 DC Parameters

7.1 Maximum Guaranteed Ratings

PARAMETER	SYMBOL	MIN	MAX	UNITS	COMMENTS
Storage Temperature	T_A	-55	150	°C	
Lead Temperature			325	°C	Soldering < 10 seconds
3.3V supply voltage	V_{DD33}, V_{DDA33}	-0.5	4.0	V	
Voltage on USB+ and USB- pins		-0.5	(3.3V supply voltage + 2) ≤ 6	V	
Voltage on GPIO10		-0.5	V_{DD33} + 0.3	V	When internal power FET operation of this pin is enabled, this pin may be simultaneously shorted to ground or any voltage up to 3.63V indefinitely, without damage to the device as long as V_{DD33} and V_{DDA33} are less than 3.63V and T_A is less than 70^oC.
Voltage on any signal pin		-0.5	V_{DD33} + 0.3	V	
Voltage on XTAL1		-0.5	4.0	V	
Voltage on XTAL2		-0.5	V_{DD18} + 0.3	V	

Note 7.1 Stresses above the specified parameters may cause permanent damage to the device. This is a stress rating only and functional operation of the device at any condition above those indicated in the operation sections of this specification is not implied.

Note 7.2 When powering this device from laboratory or system power supplies, it is important that the Absolute Maximum Ratings not be exceeded or device failure can result. Some power supplies exhibit voltage spikes on their outputs when the AC power is switched on or off. In addition, voltage transients on the AC power line may appear on the DC output. When this possibility exists, it is suggested that a clamp circuit be used.

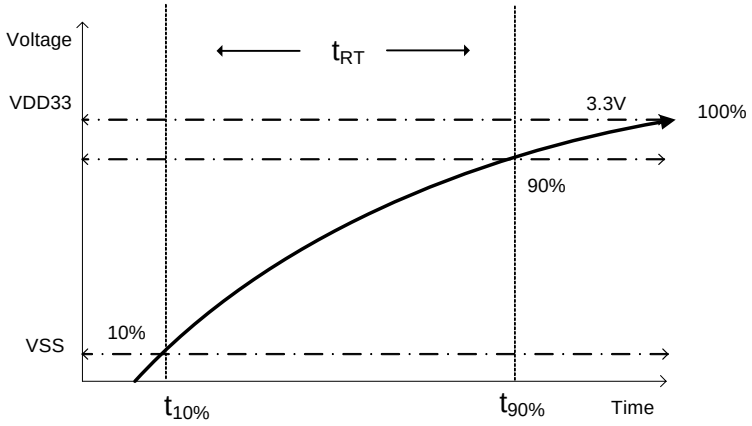


Figure 7.1 Supply Rise Time Model

7.2 Recommended Operating Conditions

PARAMETER	SYMBOL	MIN	MAX	UNITS	COMMENTS
Operating Temperature					
Commercial Part	T_A	0	70	°C	
Industrial Part	T_A	-40	85	°C	
3.3V supply voltage	V_{DD33}, V_{DDA33}	3.0	3.6	V	(Note 7.3)
3.3V supply rise time	t_{RT}	0	400	µs	
Voltage on USB+ and USB- pins		-0.3	5.5	V	If any 3.3V supply voltage drops below 3.0V, then the MAX becomes: (3.3V supply voltage) + 0.5 ≤ 5.5
Voltage on any signal pin		-0.3	V_{DD33}	V	
Voltage on XTAL1		-0.3	V_{DDA33}	V	
Voltage on XTAL2		-0.3	V_{DD18}	V	

Note 7.3 A 3.3V regulator with an output tolerance of 1% must be used if the output of the internal power FET's must support a 5% tolerance.

7.3 DC Electrical Characteristics

PARAMETER	SYMBOL	MIN	TYP	MAX	UNITS	COMMENTS
I, IPU, IPD Type Input Buffer						
Low Input Level	V_{ILI}			0.8	V	TTL Levels
High Input Level	V_{IHI}	2.0			V	
Pull Down	PD		72		µA	
Pull Up	PU		58		µA	
IS Type Input Buffer						
Low Input Level	V_{ILI}			0.8	V	TTL Levels
High Input Level	V_{IHI}	2.0			V	
Hysteresis	V_{HYSI}		420		mV	
ICLK Input Buffer						
Low Input Level	V_{ILCK}			0.5	V	
High Input Level	V_{IHCK}	1.4			V	
Input Leakage	I_{IL}	-10		+10	µA	V_{IN} = 0 to V_{DD33}
Input Leakage						
(All I and IS buffers)						
Low Input Leakage	I_{IL}	-10		+10	µA	V_{IN} = 0
High Input Leakage	I_{IH}	-10		+10	µA	V_{IN} = V_{DD33}
O12 Type Buffer						
Low Output Level	V_{OL}			0.4	V	I_{OL} = 12mA @ V_{DD33}= 3.3V
High Output Level	V_{OH}	V_{DD33} - 0.4			V	I_{OH} = -12mA @ V_{DD33}= 3.3V
Output Leakage	I_{OL}	-10		+10	µA	V_{IN} = 0 to V_{DD33} (Note 7.4)

PARAMETER	SYMBOL	MIN	TYP	MAX	UNITS	COMMENTS
I/O12, I/O12PU & I/O12PD Type Buffer						
Low Output Level	V_{OL}			0.4	V	I_{OL} = 12mA @ V_{DD33}= 3.3V
High Output Level	V_{OH}	V_{DD33} - 0.4			V	I_{OH} = -12mA @ V_{DD33}= 3.3V
Output Leakage	I_{OL}	-10		+10	µA	V_{IN} = 0 to V_{DD33} (Note 7.4)
Pull Down	PD		72		µA	
Pull Up	PU		58		µA	
IO-U (Note 7.5)						
I-R (Note 7.6)						
I/O200 Integrated Power FET for GPIO10						
High Output Current Mode	I_{OUT}	200			mA	$Vdrop_{FET}$ = 0.46V
Low Output Current Mode (Note 7.7)	I_{OUT}	100			mA	$Vdrop_{FET}$ = 0.23V
On Resistance (Note 7.7)	R_{DSON}			2.1	Ω	I_{FET} = 70mA
Output Voltage Rise Time	t_{DSON}			800	µs	C_{LOAD} = 10µF
Supply Current Unconfigured	I_{CCINIT}		80	90	mA	
Supply Current Active Full Speed	I_{CC}		110	140	mA	
High Speed	I_{CC}		135	165	mA	
Supply Current Suspend	I_{CSBY}		350	700	µA	
Industrial Temperature Suspend	I_{CSBYI}		350	900	µA	

Note 7.4 Output leakage is measured with the current pins in high impedance.

Note 7.5 See The USB 2.0 Specification, Chapter 7, for USB DC electrical characteristics

Note 7.6 RBIAS is a 3.3V tolerant analog pin.

Note 7.7 Output current range is controlled by program software, software disables FET during short circuit condition.

Note 7.8 The assignment of each Integrated Card Power FET to a designated Card Connector is controlled by both firmware and the specific board implementation. Firmware will default to

the settings listed in Table 10.1, “USB2242/USB2242i GPIO Usage (ROM Rev 0x00),” on page 23.

Note 7.9 The 3.3V supply should be at least at 75% of its operating condition before the 1.8V supply is allowed to ramp up.

7.4 Capacitance

T_A = 25°C; fc = 1MHz; V_{DD}, V_{DDP} = *1.8V*

Table 7.1 Pin Capacitance

PARAMETER	SYMBOL	LIMITS			UNIT	TEST CONDITION
		MIN	TYP	MAX		
Clock Input Capacitance	C_{XTAL}			2	pF	All pins (except USB pins and pins under test) are tied to AC ground.
Input Capacitance	C_{IN}			10	pF	
Output Capacitance	C_{OUT}			20	pF	

Chapter 8 AC Specifications

8.1 Oscillator/Clock

Crystal: Parallel Resonant, Fundamental Mode, 24 MHz ± 100ppm.

External Clock: 50% Duty cycle ± 10%, 24 MHz ± 100ppm, Jitter < 100ps rms.

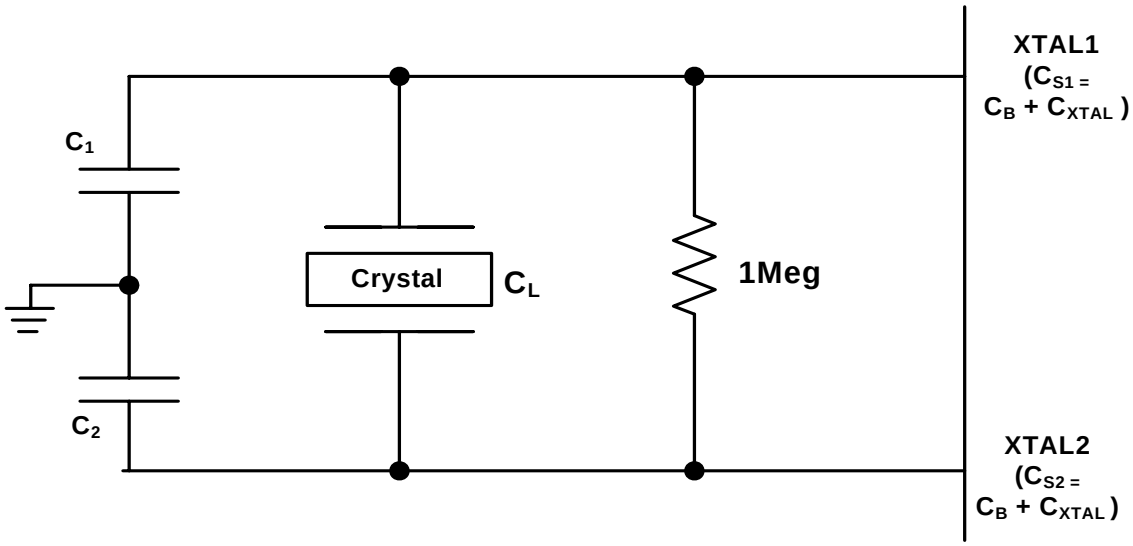


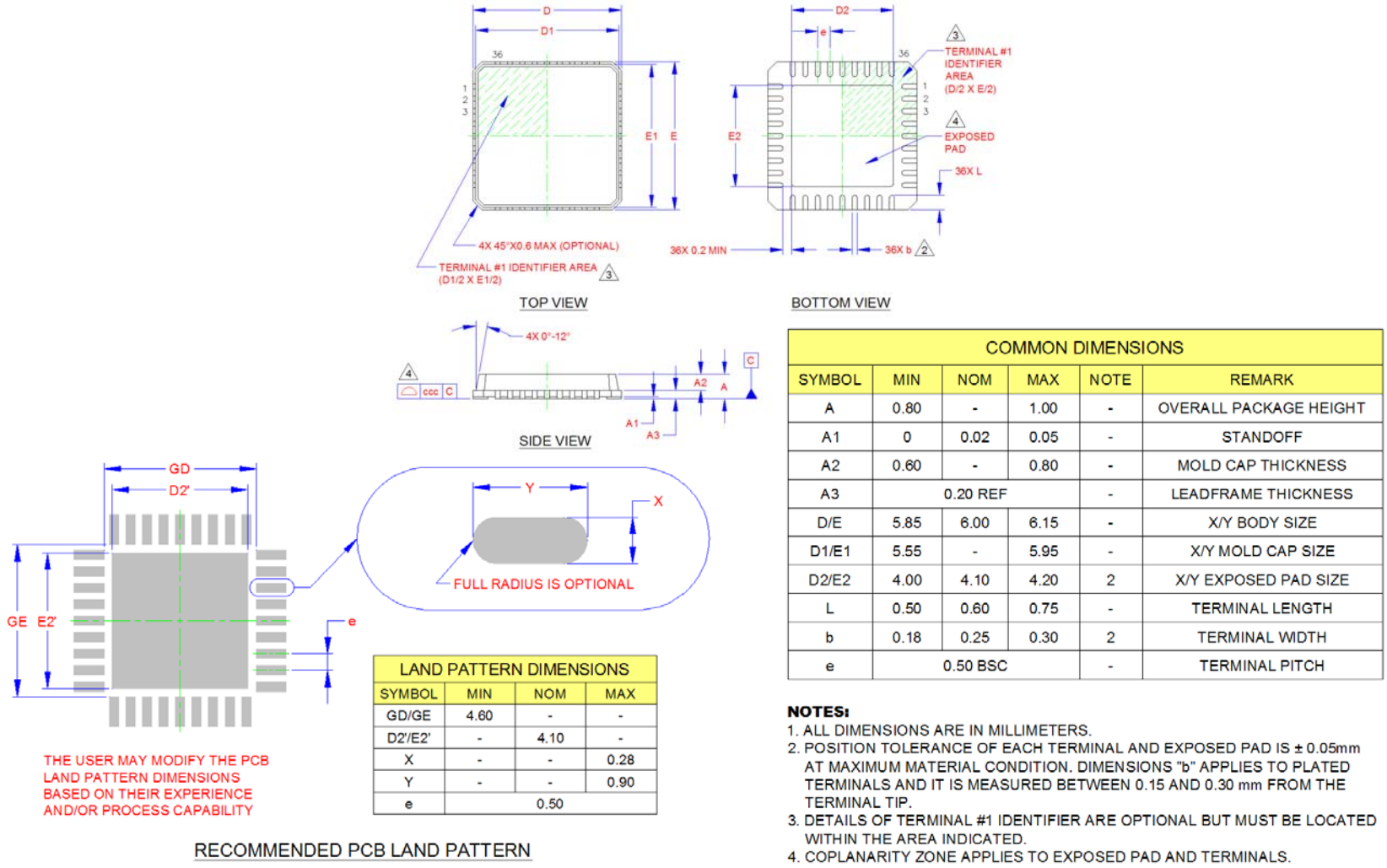
Figure 8.1 Typical Crystal Circuit

Note: C_B equals total board/trace capacitance.

$$\frac{(C_1 + C_{S1}) \times (C_2 + C_{S2})}{(C_1 + C_{S1} + C_2 + C_{S2})} = C_L$$

Figure 8.2 Formula to Find Value of C_1 and C_2

Chapter 9 Package Outline



LAND PATTERN DIMENSIONS			
SYMBOL	MIN	NOM	MAX
GD/GE	4.60	-	-
D2'/E2'	-	4.10	-
X	-	-	0.28
Y	-	-	0.90
e		0.50	

COMMON DIMENSIONS					
SYMBOL	MIN	NOM	MAX	NOTE	REMARK
A	0.80	-	1.00	-	OVERALL PACKAGE HEIGHT
A1	0	0.02	0.05	-	STANDOFF
A2	0.60	-	0.80	-	MOLD CAP THICKNESS
A3		0.20 REF		-	LEADFRAME THICKNESS
D/E	5.85	6.00	6.15	-	X/Y BODY SIZE
D1/E1	5.55	-	5.95	-	X/Y MOLD CAP SIZE
D2/E2	4.00	4.10	4.20	2	X/Y EXPOSED PAD SIZE
L	0.50	0.60	0.75	-	TERMINAL LENGTH
b	0.18	0.25	0.30	2	TERMINAL WIDTH
e		0.50 BSC		-	TERMINAL PITCH

NOTES:
1. ALL DIMENSIONS ARE IN MILLIMETERS.
2. POSITION TOLERANCE OF EACH TERMINAL AND EXPOSED PAD IS ± 0.05mm AT MAXIMUM MATERIAL CONDITION. DIMENSIONS "b" APPLIES TO PLATED TERMINALS AND IT IS MEASURED BETWEEN 0.15 AND 0.30 mm FROM THE TERMINAL TIP.
3. DETAILS OF TERMINAL #1 IDENTIFIER ARE OPTIONAL BUT MUST BE LOCATED WITHIN THE AREA INDICATED.
4. COPLANARITY ZONE APPLIES TO EXPOSED PAD AND TERMINALS.

Figure 9.1 USB2242/USB2242i 36-QFN, 6x6mm Body, 0.5mm Pitch

Chapter 10 GPIO Usage

Table 10.1 USB2242/USB2242i GPIO Usage (ROM Rev 0x00)

NAME	ACTIVE LEVEL	SYMBOL	DESCRIPTION AND NOTE
GPIO1	H	LED1	LED indicator
GPIO2	H	RXD / SDA	Receive Port of Debugger / Serial EEPROM Data
GPIO4	USER	GPIO	User defined
GPIO7	H	TXD / SCK / MS_SKT_SEL	Transmit Port of Debugger / Serial EEPROM Clock / Memory Stick Socket (1 = 8 bit; 0 = 4 bit)
GPIO10	L	CRD_PWR	Card Power Control
GPIO12	L	MS_INS	Memory Stick Card Insertion
GPIO14	USER	GPIO	User defined
GPIO15	USER	GPIO	User defined